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### FAX MESSAGE

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**United States Patent and Trademark Office** 

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#### Comments:

# PLEASE HAND DELIVER TO EXAMINER DEB

Re:

U.S. Patent Application No. 09/893,995

Attorney Docket No.: 049128-5023

## Dear Examiner Deb:

Per our telephone conversations of yesterday and today, please find enclosed proposed amendments to claim 1 to be included in an Examiner's Amendment. Since we authorize only these amendments to claim 1, please call me directly at my telephone number above if these proposed amendments to claim 1 are not acceptable.

With best regards.

PAGE 1/2 \* RCVD AT 3/3/2004 1:17:53 PM [Eastern Standard Time] \* SVR:USPTO-EFXRF-1/25 \* DNIS:2732228 \* CSID: \* DURATION (mm-ss):01-14

Patent Application No. 09/893,995 Attorney Docket No. 049128-5023 Examiner Anjan K. Deb Art Unit 2858 March 3, 2004

# PROPOSED CLAIM AMENDMENTS FOR EXAMINER'S AMENDMENT

Claim 1 (Proposed): A probe frame assembly of an inspection apparatus for a liquid crystal display device, comprising:

at least two separate probe frame bodies provided above an upper surface of a chuck <u>loaded</u> with a glass substrate having a plurality of liquid crystal display <u>panels</u> for simultaneously applying test pattern signals to shorting bars provided on a the plurality of liquid crystal display panels disposed on a glass substrate.